

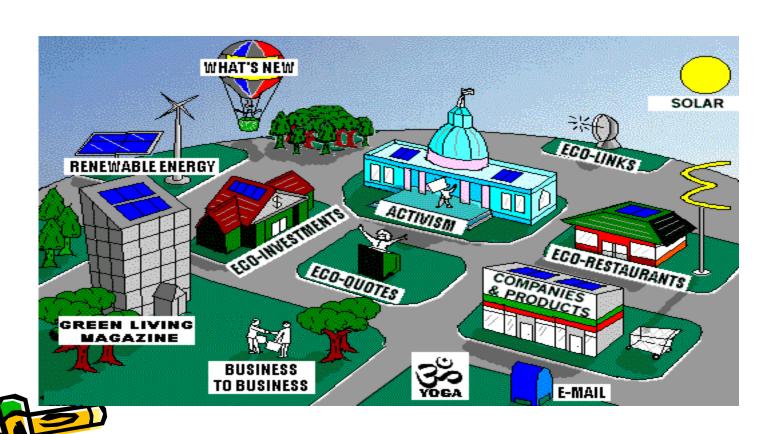


MULTIFUNCTIONAL THIN FILMS OBTAINED BY MAPLE AND PLD TECHNIQUES

LUIZA ADELINA CIUCU

National Institute for Laser Plasma & Radiation Physics (INFLPR), Bucharest, Romania

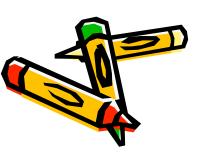
Motivation: replacing piezoelectric and ferroelectric lead-based materials



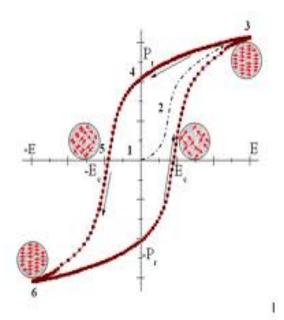
Motivation of BCTZ lead-free material study: replacing piezoelectric and ferroelectric lead-based materials







Ferroelectric materials

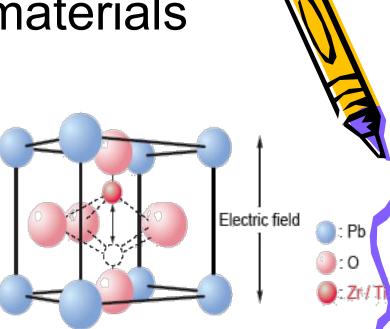


Properties

Spontaneous polarization in the absence applied electrical field.

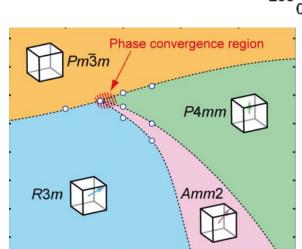
- Extremely high dielectric constant
- Non-linear dielectric response to an applied electrical field.
- High strain
 response to
 applied electrical
 field ⇒
- piezoelectricity
- ✓ Strong variation in polarization with temperature
 ⇒ pyroelectricity

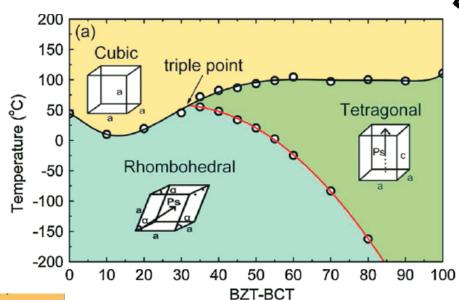




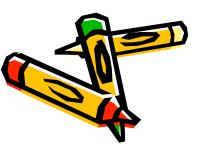
Solid solution $(1-x)Ba(Ti_{0.8}Zr_{0.2})O_3 - x(Ba_{0.7}Ca_{0.3})TiO_3$ BCTZ- complex phase diagram

BCTZ ceramic systems are known to have high dielectric constant and high dielectric tunability. Impressive piezoelectric activity for composition 0.5Ba(Zr_{0.2}Ti_{0.8})O₃–0.5(Ba_{0.7}Ca_{0.3})TiO₃ – higher that for PZT Beside MPB region, a C-T-R triple point or





W. Liu and X. Ren, Phys. Rev. Lett. 103, 257602 (2009))

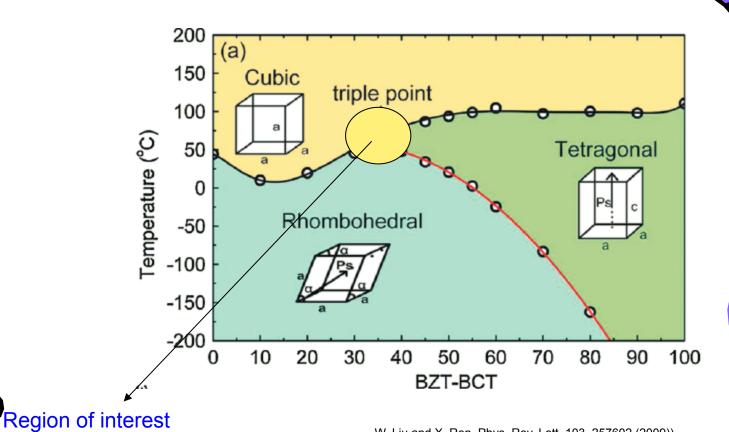


tricritical point

has been found.

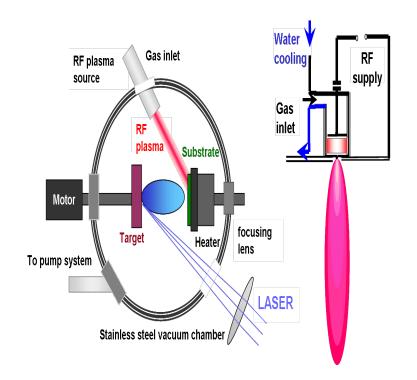
D.S. Keeble et al, Appl. Phys. Lett. 102, 092903 (2013)

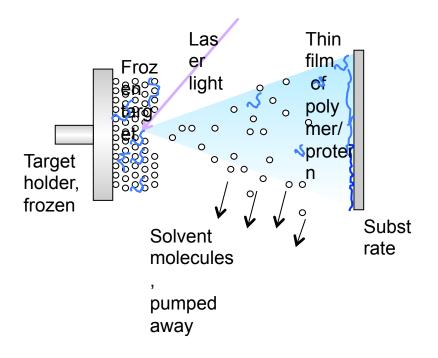
BCTZ complex phase diagram



W. Liu and X. Ren, Phys. Rev. Lett. 103, 257602 (2009))

Laser methods





PLD technique

MAPLE technique



Deposition methods of piezoelectric active layers

- Pulsed Laser Deposition, PLD, epitaxial thin films can be obtained for maximum piezoelectric activity. High temperatures are required during deposition. Piezoelectric active layers have been obtained on different supports (MgO, Al2O3, SrTiO3)
- Matrix assisted Pulsed Laser Evaporations, MAPLE, room temperature deposition conditions, high areas can be obtained. Flexible supports have been used for piezoeletric active layers: kapton, Pt/Kapton



Piezoelectric epitaxial thin films deposition by Pulsed Laser Deposition

Morphology of the surface- Atomic Force Microscopy

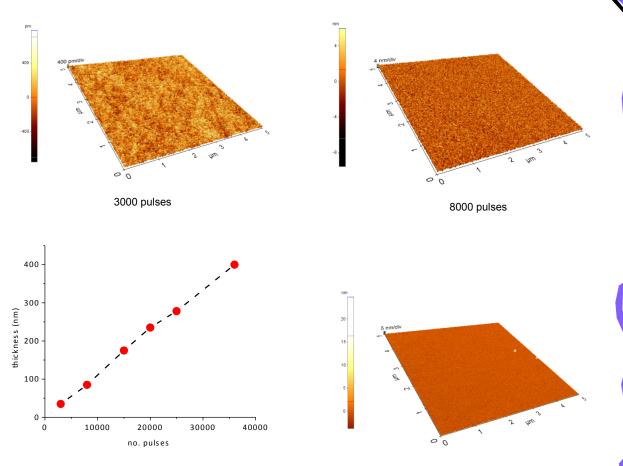
Ceramic target:

 $Ba_{0.865}Ca_{0.135}Ti_{0.89}Zr$ _{0.11} O_3 (1500 ${}^{0}C - 4h$)

Substrates: Nb:STO

Number of pulses:

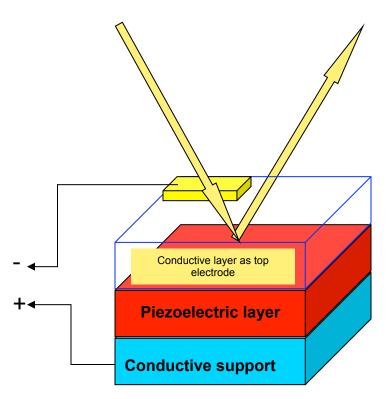
3000-36.0000

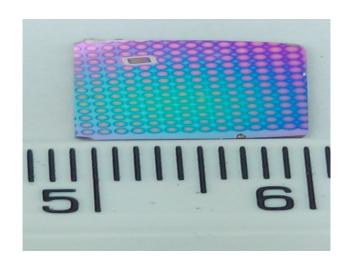


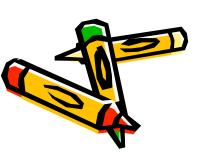


Demo sample of epitaxial layer for electrical testing pulses

Piezoelectric studies: heterostructure to be obtained for integration of the piezoelectric active layer into a testing device

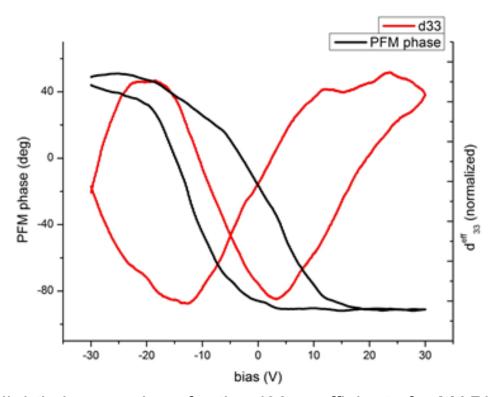






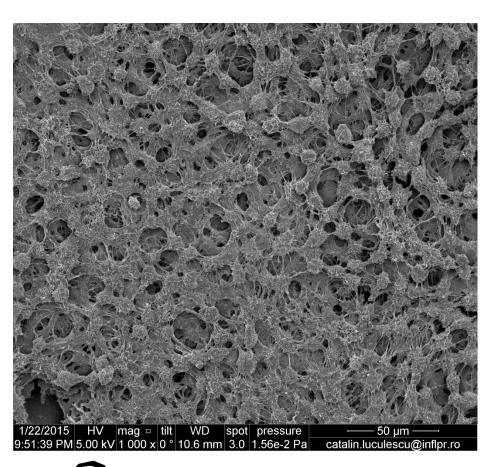
Piezoelectric studies

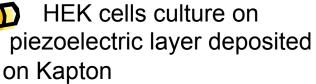
-piezoresponse force microscopy technique has been employed for measuring the piezoelectric d_{33} coefficients of the thin films.

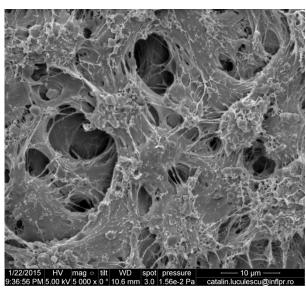


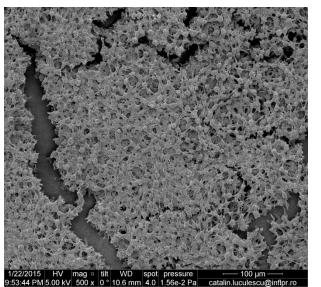
Slightly lower values for the d33 coefficients for MAPLE thin films, but the major advantage is that the films can be obtained at room temperature from a frozen target.

Biocompatibility studies performed on piezoelectric active layers.



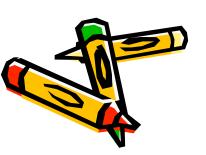






CONCLUSIONS:

- Replacing piezoelectric and ferroelectric lead-based materials
- Spontaneous polarization in the absence applied electrical field.
- High strain response to applied electrical field.





Thank you

ciucu.luiza@yahoo.com

